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TEST REPORT

Product : OBE Smart Projector

Trade mark : N/A

Model/Type reference : C2D, C2D******("*"=0-9, A-Z, a-z, -, _or

any character such as a space)

Serial Number : N/A

Report Number : EED32R81471402

FCC ID : 2BRQF-C2D Date of Issue : Sep. 10, 2025

Test Standards : 47 CFR Part 15 Subpart C

Test result : PASS

Prepared for:

OBE TECHNOLOGY INC 595 S Green Valley Pkwy, APT 2322, Henderson, Nevada 89012, United States

Prepared by:

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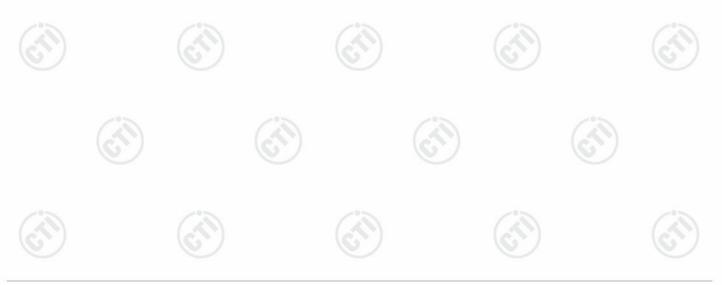
2 Test Summary

L 163t Outililiary		
Test Item	Test Requirement	Result
Antenna Requirement	47 CFR Part 15, Subpart C Section 15.203/15.247 (c)	PASS
AC Power Line Conducted Emission	47 CFR Part 15, Subpart C Section 15.207	PASS
Maximum Conducted Output Power	·	
20dB Emission Bandwidth	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	PASS
Carrier Frequency Separation	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	PASS
Number of Hopping Channels	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	PASS
Time of Occupancy	47 CFR Part 15, Subpart C Section 15.247 (a)(1)	PASS
Pseudorandom Frequency Hopping Sequence	47 CFR Part 15, Subpart C Section 15.247(b)(4)	PASS
Band Edge Measurements	47 CFR Part 15, Subpart C Section 15.247(d)	PASS
Conducted Spurious Emissions	47 CFR Part 15, Subpart C Section 15.247(d)	PASS
Radiated Spurious emissions	47 CFR Part 15, Subpart C Section 15.205/15.209	PASS
Restricted bands around fundamental frequency	47 CFR Part 15, Subpart C Section 15.205/15.209	PASS

Remark:

Model No.: C2D, C2D******("*"=0-9, A-Z, a-z, -, _or any character such as a space)

Only the model C2D was tested, since the electrical circuit design, layout, components used and internal wiring were identical for the above models, with difference being color of appearance and model name.





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3 General Information

3.1 Client Information

Applicant:	OBE TECHNOLOGY INC
Address of Applicant:	595 S Green Valley Pkwy, APT 2322, Henderson, Nevada 89012, United States
Manufacturer:	Shenzhen Orange Digital Technology Co.,Ltd.
Address of Manufacturer:	Room 2305, Building 2, Phase 6, Vanke Yuncheng, Tongfa South Road, Xili Community, Xili Street, Nanshan District, Shenzhen, Guangdong Province, P.R. China
Factory:	Chuzhou OBE Digital Technology Co.,LTD
Address of Factory:	Floor 3th, building 21& building 7, Zhaoyang Industrial Park, 801 century avenue, Chuzhou city, Anhui Province, P.R. China

3.2 General Description of EUT

	Product Name:	OBE Smart Projector					
	Model No.:	C2D, C2D*****("*"=0-9, A-Z, a-z, -, _or any character such as a space)					
	Test Model No.:	C2D					
	Trade Mark:	N/A					
	Product Type:	☐ Mobile ☐ Portable ☒ Fix Location					
	Operation Frequency:	2402MHz-2480MHz					
	Modulation Technique:	Frequency Hopping Spread Spectrum(FHSS)					
	Modulation Type:	GFSK, π/4DQPSK, 8DPSK					
0.9	Number of Channel:	79					
§	Hopping Channel Type:	Adaptive Frequency Hopping systems					
	Antenna Type:	Internal antenna					
	Antenna Gain:	5.16dBi					
	Power Supply:	Adapter: Input:AC 100V-240V~50/60Hz 2A,Output:DC 19V/6.3A					
	Test Voltage: AC 120V						
	Sample Received Date:	Aug. 26, 2025					
	Sample tested Date: Aug. 26, 2025 to Sep. 01, 2025						







	_		_		_		_
Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)	Channel	Frequency (MHz)
0	2402	20	2422	40	2442	60	2462
1	2403	21	2423	41	2443	61	2463
2	2404	22	2424	42	2444	62	2464
3	2405	23	2425	43	2445	63	2465
4	2406	24	2426	44	2446	64	2466
5	2407	25	2427	45	2447	65	2467
6	2408	26	2428	46	2448	66	2468
7	2409	27	2429	47	2449	67	2469
8	2410	28	2430	48	2450	68	2470
9	2411	29	2431	49	2451	69	2471
10	2412	30	2432	50	2452	70	2472
11	2413	31	2433	51	2453	71	2473
12	2414	32	2434	52	2454	72	2474
13	2415	33	2435	53	2455	73	2475
14	2416	34	2436	54	2456	74	2476
15	2417	35	2437	55	2457	75	2477
16	2418	36	2438	56	2458	76	2478
17	2419	37	2439	57	2459	77	2479
18	2420	38	2440	58	2460	78	2480
19	2421	39	2441	59	2461	_0	

Note:

In section 15.31(m), regards to the operating frequency range over 10 MHz, the Lowest frequency, the middle frequency, and the highest frequency of channel were selected to perform the test, and the selected channel see below:

Channel	Frequency(MHz)		
The lowest channel (CH0)	2402		
The middle channel (CH39)	2441		
The highest channel (CH78)	2480		















Test Configuration 3.3

EUT Test Software Settings):					
Test Software:	SecureCRT.exe					
EUT Power Grade:	Default (Power level is built-in set parameters and cannot be changed and selected)					
Use test software to set the lot transmitting of the EUT.	owest frequency, the middle frequency and	I the highest frequency keep				
Mode	Channel	Frequency(MHz)				
	CH0	2402				
DH1/DH3/DH5	CH39	2441				
	CH78	2480				
	CH0	2402				
2DH1/2DH3/2DH5	CH39	2441				
	CH78	2480				
	CH0	2402				
3DH1/3DH3/3DH5	CH39	2441				
	CH78	2480				





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3.4 Test Environment

Operating Environment	t:							
Radiated Spurious Emissions:								
Temperature:	22~25.0 °C							
Humidity:	50~55 % RH		100		(3)			
Atmospheric Pressure:	1010mbar		(0)		(6)			
Conducted Emissions:								
Temperature:	22~25.0 °C							
Humidity:	50~55 % RH	-05		100				
Atmospheric Pressure:	1010mbar	(47)		(47)				
RF Conducted:								
Temperature:	22~25.0 °C							
Humidity:	50~55 % RH							
Atmospheric Pressure:	1010mbar		(20)					

3.5 Description of Support Units

The EUT has been tested with associated equipment below.

1) Support equipment

Description	Manufacturer	Model No.	Certification	Supplied by
Netbook	Asus	FL8700Jp1065-	FCC&CE	СТІ
TACIDOOK	Adus	0D8GXYQ2X10	1 OOGOL	011

3.6 Test Location

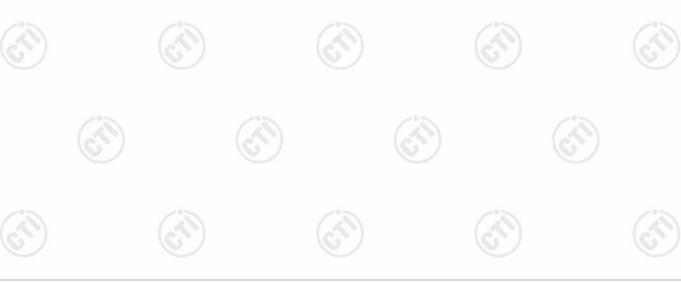
All tests were performed at:

Centre Testing International Group Co., Ltd

Hongwei Industrial Park, Zone 70, Bao'an District, Shenzhen, Guangdong, China

Telephone: +86 (0) 755 33683668 Fax:+86 (0) 755 33683385

No tests were sub-contracted. FCC Designation No.: CN1164

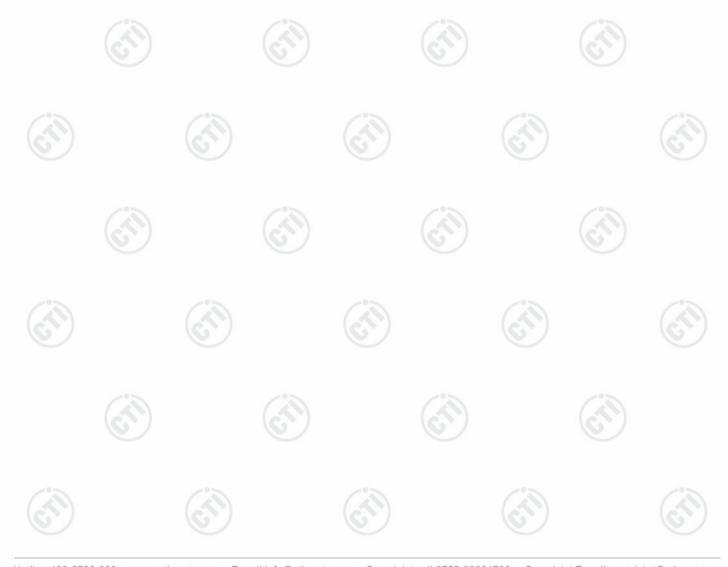






3.7 Measurement Uncertainty (95% confidence levels, k=2)

No.	Item	Measurement Uncertainty		
1	Radio Frequency	7.9 x 10 ⁻⁸		
	DE manuar conducted	0.46dB (30MHz-1GHz)		
2	RF power, conducted	0.55dB (1GHz-40GHz)		
		3.3dB (9kHz-30MHz)		
2	Dedicted Country and size to the	4.3dB (30MHz-1GHz)		
3	Radiated Spurious emission test	4.5dB (1GHz-18GHz)		
(3)		3.4dB (18GHz-40GHz)		
67	O and the state of	3.5dB (9kHz-150kHz)		
4	Conduction emission	3.1dB (150kHz-30MHz)		
5	Temperature test	0.64°C		
6	Humidity test	3.8%		
7	DC power voltages	0.026%		







3.8 **Equipment List**

	RF test system							
Equipment	Manufacturer	Model No.	Serial Number	Cal. Date (mm-dd-yyyy)	Cal. Due date (mm-dd-yyyy)			
Spectrum Analyzer	Keysight	N9010A	MY54510339	12-05-2024	12-04-2025			
Signal Generator	Keysight	N5182B	MY53051549	11-30-2024	11-29-2025			
DC Power	Keysight	E3642A	MY56376072	11-30-2024	11-29-2025			
Communication test	R&S	CMW500	169004	03-03-2025	03-02-2026			
RF control unit(power unit)	JS Tonscend	JS0806-2	22G8060592	07-20-2025	07-192026			
Wi-Fi 7GHz Band Extendder	JS Tonscend	TS-WF7U2	2206200002	05-12-2025	05-11-2026			
High-low temperature test chamber	Dong Guang Qin Zhuo	LK-80GA	QZ20150611879	11-30-2024	11-29-2025			
Temperature/	biaozhi	HM10	1804186	05-26-2025	05-25-2026			
BT&WI-FI Automatic test software	JS Tonscend	JS1120-3	V3.3.20	N/A	N/A			
Spectrum Analyzer	R&S	FSV3044	101509	02-14-2025	02-13-2026			

























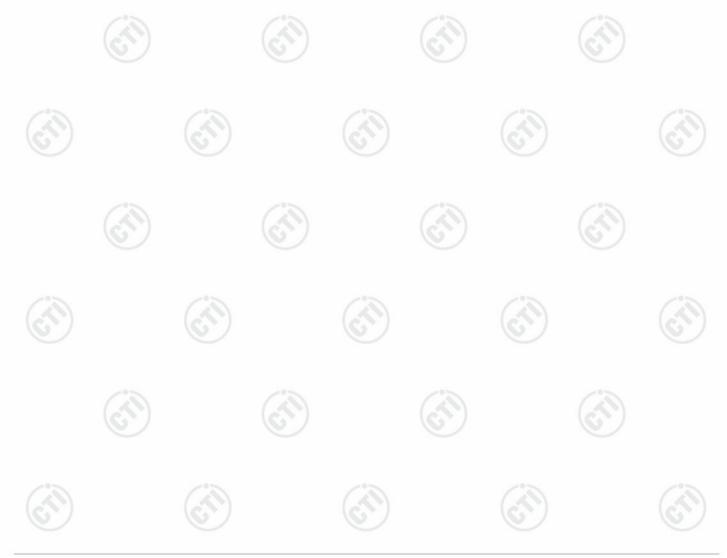






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Conducted disturbance Test								
Equipment	Manufacturer	Model No.	Serial Number	Cal. date (mm-dd-yyyy)	Cal. Due date (mm-dd-yyyy)			
Receiver	R&S	ESCI	100435	04-08-2025	04-07-2026			
Temperature/ Humidity Indicator	Defu	TH128	/	03-31-2025	03-30-2026			
LISN	R&S	ENV216	100098	09-19-2024	09-18-2025			
Barometer	changchun	DYM3	1188	05-14-2025	05-13-2026			
Test software	Fara	EZ-EMC	EMC-CON 3A1.1	N/A	N/A			
Capacitive voltage probe	Schwarzbeck	CVP 9222C	00124	06-07-2025	06-06-2026			
ISN	TESEQ	ISN T800	30297	12-05-2024	12-04-2025			





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			Serial	Cal. date	Cal. Due date	
Equipment	Manufacturer	Model No.	Number	(mm-dd-yyyy)	(mm-dd-yyyy)	
3M Chamber & Accessory Equipment	TDK	SAC-3		01/13/2024	01/12/2027	
Receiver	R&S	ESCI7	100938- 003	09/07/2024	09/06/2025	
Spectrum Analyzer	R&S	FSV40	101200	08/11/2025	08/10/2026	
TRILOG Broadband Antenna	schwarzbeck	VULB 9163	9163-618	05/14/2025	05/13/2026	
Loop Antenna	Schwarzbeck	FMZB 1519B	1519B-076	04/07/2025	04/06/2026	
Microwave Preamplifier	Tonscend	EMC051845SE	980380	12/05/2024	12/04/2025	
Horn Antenna	A.H.SYSTEMS	SAS-574	374	07/02/2023	07/01/2026	
Horn Antenna	ETS-LINGREN	BBHA 9120D	9120D- 1869	04/07/2025	04/06/2026	
Preamplifier	Agilent	11909A	12-1	03/03/2025	03/02/2026	
Preamplifier	Preamplifier CD		6041.6042	05/26/2025	05/25/2026	
Test software	Fara	EZ-EMC	EMEC- 3A1-Pre	N/A	N/A	
Cable line	Fulai(7M)	SF106	5219/6A	01/13/2024	01/12/2027	
Cable line	Fulai(6M)	SF106	5220/6A	01/13/2024	01/12/2027	
Cable line	Fulai(3M)	SF106	5216/6A	01/13/2024	01/12/2027	
Cable line	Fulai(3M)	SF106	5217/6A	01/13/2024	01/12/2027	













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		3M full-anechoic	Chamber			
Equipment	Manufacturer	Model No.	Serial Number	Cal. Date (mm-dd-yyyy)	Cal. Due date (mm-dd-yyyy)	
Fully Anechoic Chamber	TDK	FAC-3		01-09-2024	01-08-2027	
Receiver	Keysight	N9038A	MY57290136	01-04-2025	01-03-2026	
Spectrum Analyzer	Keysight	N9020B	MY57111112	01-14-2025	01-13-2026	
Spectrum Analyzer	Keysight	N9030B	MY57140871	01-14-2025	01-13-2026	
TRILOG Broadband Antenna	Schwarzbeck	VULB 9163	9163-1148	04-12-2025	04-11-2026	
Horn Antenna	Schwarzbeck	BBHA 9170	9170-832	04-12-2025	04-11-2026	
Horn Antenna	ETS-LINDGREN	3117	57407	06-29-2025	06-28-2026	
Preamplifier	EMCI	EMC001330	980563	03-03-2025	03-02-2026	
Preamplifier	Tonscend	TAP-011858	AP21B806112	07-07-2025	07-06-2026	
Preamplifier	Tonscend	EMC051845SE	980380	12-05-2024	12-04-2025	
Communication test set	R&S	CMW500	102898	01-04-2025	01-03-2026	
Temperature/	biaozhi	GM1360	EE1186631	03-31-2025	03-30-2026	
RSE Automatic test software	JS Tonscend	JS36-RSE	V4.0.0.0	N/A	N/A	
Cable line	Times	SFT205-NMSM-2.50M	394812-0001	01-09-2024	01-08-2027	
Cable line	Times	SFT205-NMSM-2.50M	394812-0002	01-09-2024	01-08-2027	
Cable line	Times	SFT205-NMSM-2.50M	394812-0003	01-09-2024	01-08-2027	
Cable line	Times	SFT205-NMSM-2.50M	393495-0001	01-09-2024	01-08-2027	
Cable line	Times	EMC104-NMNM-1000	SN160710	01-09-2024	01-08-2027	
Cable line	Times	SFT205-NMSM-3.00M	394813-0001	01-09-2024	01-08-2027	
Cable line	Times	SFT205-NMNM-1.50M	381964-0001	01-09-2024	01-08-2027	
Cable line	Times	SFT205-NMSM-7.00M	394815-0001	01-09-2024	01-08-2027	
Cable line	Times	HF160-KMKM-3.00M	393493-0001	01-09-2024	01-08-2027	

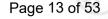












4 Test results and Measurement Data

4.1 Antenna Requirement

Standard requirement: 47 CFR Part 15C Section 15.203 /247(c)

15.203 requirement:

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited.

15.247(b) (4) requirement:

The conducted output power limit specified in paragraph (b) of this section is based on the use of antennas with directional gains that do not exceed 6 dBi. Except as shown in paragraph (c) of this section, if transmitting antennas of directional gain greater than 6 dBi are used, the conducted output power from the intentional radiator shall be reduced below the stated values in paragraphs (b)(1), (b)(2), and (b)(3) of this section, as appropriate, by the amount in dB that the directional gain of the antenna exceeds 6 dBi.

EUT Antenna: Please see Internal photos

The antenna is internal antenna. The best case gain of the antenna is 5.16dBi.





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4.2 AC Power Line Conducted Emissions

Test Requirement: ANSI C63.10: 2013 Test Frequency Range: Receiver setup: Receiver setup: Imit: Frequency range (MHz) Cuasi-peak Average 0.15-0.5 66 to 56* 56 to 46* 0.5-5 56 46 5-30 Decreases with the logarithm of the frequency. Test Setup: Test Procedure: 1) The mains terminal disturbance voltage test was conducted in a room. 2) The EUT was connected to AC power source through a LISN 1 (Li Impedance. The power cables of all other units of the EUT were connected to a second LISN 2, which was bonded to the ground reference plane in the same way as the LISN 1 for the unit being measured. A multiple socket outlet strip was used to connect multipower cables to a single LISN provided the rating of the LISN was exceeded. 3) The tabletop EUT was placed upon a non-metallic table 0.8m about the content of the EUT was exceeded. 3) The tabletop EUT was placed upon a non-metallic table 0.8m about the content of the EUT was exceeded.	
Test Frequency Range: RBW=9 kHz, VBW=30 kHz, Sweep time=auto	
Receiver setup: RBW=9 kHz, VBW=30 kHz, Sweep time=auto Limit: Frequency range (MHz) Quasi-peak Average 0.15-0.5 66 to 56* 56 to 46* 0.5-5 56 46 5-30 60 50 * Decreases with the logarithm of the frequency. Test Setup: Test Procedure: 1) The mains terminal disturbance voltage test was conducted in a room. 2) The EUT was connected to AC power source through a LISN 1 (Li Impedance Stabilization Network) which provides a 50Ω/50µH + 5 impedance. The power cables of all other units of the EUT were connected to a second LISN 2, which was bonded to the ground reference plane in the same way as the LISN 1 for the unit being measured. A multiple socket outlet strip was used to connect multipower cables to a single LISN provided the rating of the LISN was exceeded.	
Limit: Frequency range (MHz)	
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Test Setup: Test Procedure: 1) The mains terminal disturbance voltage test was conducted in a room. 2) The EUT was connected to AC power source through a LISN 1 (Li Impedance Stabilization Network) which provides a 50\(\Omega/150\text{µH} + 5\) impedance. The power cables of all other units of the EUT were connected to a second LISN 2, which was bonded to the ground reference plane in the same way as the LISN 1 for the unit being measured. A multiple socket outlet strip was used to connect multipower cables to a single LISN provided the rating of the LISN was exceeded.	6
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power cables to a single LISN provided the rating of the LISN was exceeded.	
exceeded.	tiple
	s not
3) The tabletop EUT was placed upon a non-metallic table 0.8m above	(:)
ground reference plane. And for floor-standing arrangement, the E	
placed on the horizontal ground reference plane,	LUT Was
4) The test was performed with a vertical ground reference plane. Th	ne rear
of the EUT shall be 0.4 m from the vertical ground reference plane	e. The
vertical ground reference plane was bonded to the horizontal grou	
reference plane. The LISN 1 was placed 0.8 m from the boundary	
unit under test and bonded to a ground reference plane for LISNs	
mounted on top of the ground reference plane. This distance was between the closest points of the LISN 1 and the EUT. All other ur	
the EUT and associated equipment was at least 0.8 m from the LIS	
5) In order to find the maximum emission, the relative positions of	6.

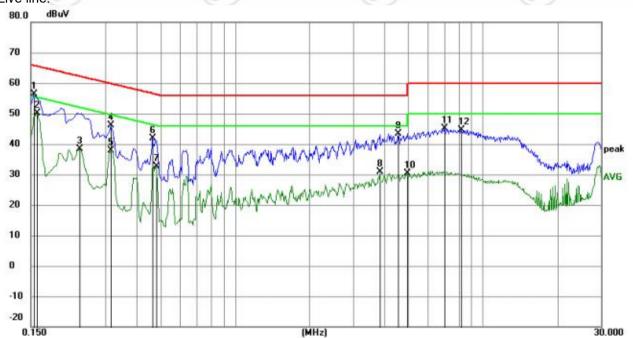


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	equipment and all of the interface cables must be changed according to ANSI C63.10: 2013 on conducted measurement.
Exploratory Test Mo	Non-hopping transmitting mode with all kind of modulation and all kind of data type at the lowest, middle, high channel.
Final Test Mode:	Through Pre-scan, find the DH5 of data type and GFSK modulation at the lowest channel is the worst case. Only the worst case is recorded in the report.
Test Results:	Pass

Measurement Data





No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin			
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment	
1		0.1545	46.18	10.28	56.46	65.75	-9.29	QP		
2	*	0.1590	39.81	10.27	50.08	55.52	-5.44	AVG		
3		0.2355	28.26	10.18	38.44	52.25	-13.81	AVG		
4		0.3165	35.95	10.12	46.07	59.80	-13.73	QP		
5		0.3165	27.79	10.12	37.91	49.80	-11.89	AVG		
6		0.4650	31.68	10.08	41.76	56.60	-14.84	QP		
7		0.4830	22.59	10.08	32.67	46.29	-13.62	AVG		
8		3.8400	20.81	10.10	30.91	46.00	-15.09	AVG		
9		4.5645	33.30	10.08	43.38	56.00	-12.62	QP		
10		4.9515	20.21	10.06	30.27	46.00	-15.73	AVG		
11		6.9945	35.09	10.03	45.12	60.00	-14.88	QP		
12		8.1825	34.58	10.00	44.58	60.00	-15.42	QP		







Remark:

- 1. The following Quasi-Peak and Average measurements were performed on the EUT:
- 2. Final Test Level =Receiver Reading + LISN Factor + Cable Loss.
- 3. If the Peak value under Average limit, the Average value is not recorded in the report.

















Neutral line: 80.0 70 60 50 40 30 20 10 -10 (MHz) 30.000

No.	Mk.	Freq.	Reading Level	Correct	Measure- ment	Limit	Margin		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1		0.1545	46.60	10.28	56.88	65.75	-8.87	QP	
2	*	0.1590	39.82	10.27	50.09	55.52	-5.43	AVG	
3		0.2175	29.11	10.20	39.31	52.91	-13.60	AVG	
4		0.2580	41.19	10.16	51.35	61.50	-10.15	QP	
5		0.3209	28.49	10.12	38.61	49.68	-11.07	AVG	
6		0.4740	23.18	10.08	33.26	46.44	-13.18	AVG	
7		0.4830	35.34	10.08	45.42	56.29	-10.87	QP	
8		0.6225	32.56	10.11	42.67	56.00	-13.33	QP	
9		0.6405	21.90	10.11	32.01	46.00	-13.99	AVG	
10		0.8025	29.56	10.18	39.74	56.00	-16.26	QP	
11		4.7355	29.52	10.07	39.59	56.00	-16.41	QP	
12		29.4360	22.48	9.82	32.30	50.00	-17.70	AVG	

Remark:

- 1. The following Quasi-Peak and Average measurements were performed on the EUT:
- 2. Final Test Level =Receiver Reading + LISN Factor + Cable Loss.
- 3. If the Peak value under Average limit, the Average value is not recorded in the report.













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4.3 Maximum Conducted Output Power

/ 23	
Test Requireme	nt: 47 CFR Part 15C Section 15.247 (b)(1)
Test Method:	ANSI C63.10:2013
Test Setup:	RF test System Instrument Remark: Offset=Cable loss+ attenuation factor.
Test Procedure	Use the following spectrum analyzer settings: Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel RBW > the 20 dB bandwidth of the emission being measured VBW ≥ RBW Sweep = auto Detector function = peak Trace = max hold Allow the trace to stabilize. Use the marker-to-peak function to set the marker to the peak of the emission.
Limit:	21dBm
Exploratory Tes	t Mode: Non-hopping transmitting with all kind of modulation and all kind of data type
Final Test Mode	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of π/4DQPSK modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type.
Test Results:	Refer to Appendix A





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4.4 20dB Emission Bandwidth

1					
Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)				
Test Method:	ANSI C63.10:2013				
Test Setup:	RF test Control Control Control Power Supply Power Found Table Remark: Offset=Cable loss+ attenuation factor.				
Test Procedure:	 The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement. Set to the maximum power setting and enable the EUT transmit continuously. Use the following spectrum analyzer settings for 20dB Bandwidth measurement. Span = approximately 2 to 5 times the 20 dB bandwidth, centered on a hopping channel; 1%≤RBW ≤5% of the 20 dB bandwidth; VBW≥3RBW; Sweep = auto; Detector function = peak; Trace = max hold. Measure and record the results in the test report. 				
Limit:	NA				
Exploratory Test Mode:	Non-hopping transmitting with all kind of modulation and all kind of data type				
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of $\pi/4DQPSK$ modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type.				
Test Results:	Refer to Appendix A				





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4.5 Carrier Frequency Separation

	1 20 70 1	1 (6, 9)					
	Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)					
	Test Method:	ANSI C63.10:2013					
(0.00)	Test Setup:	Control Computer Power Supply Power Supply Table RF test System System Instrument Table					
		Remark: Offset=Cable loss+ attenuation factor.					
(Test Procedure:	 The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement. Set to the maximum power setting and enable the EUT transmit continuously. Enable the EUT hopping function. Use the following spectrum analyzer settings: Span = wide enough to capture the peaks of two adjacent channels; RBW is set to approximately 30% of the channel spacing, adjust as necessary to best identify the center of each individual channel; VBW≥RBW; Sweep = auto; Detector function = peak; Trace = max hold. Use the marker-delta function to determine the separation between the peaks of the adjacent channels. Record the value in report. 					
	Limit:	Frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater.					
	Exploratory Test Mode:	Hopping transmitting with all kind of modulation and all kind of data type					
	Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of $\pi/4DQPSK$ modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type.					
ŝ	Test Results:	Refer to Appendix A					
_							

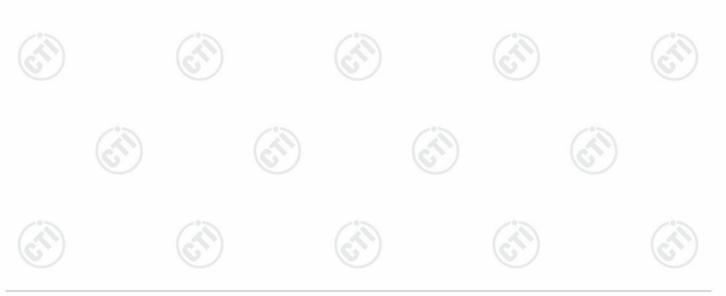




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4.6 Number of Hopping Channel

1.50.70	Lennius Lenniu			
Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)			
Test Method:	ANSI C63.10:2013			
Test Setup:	RF test System Power Power Supply Table RF test System Instrument Remark: Offset=Cable loss+ attenuation factor.			
Test Procedure:	 The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement. Set to the maximum power setting and enable the EUT transmit continuously. Enable the EUT hopping function. Use the following spectrum analyzer settings: Span = the frequency band of operation; set the RBW to less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller; VBW≥RBW; Sweep= auto; Detector function = peak; Trace = max hold. The number of hopping frequency used is defined as the number of total channel. Record the measurement data in report. 			
Limit:	Frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels.			
Test Mode:	Hopping transmitting with all kind of modulation			
Test Results:	Refer to Appendix A			





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4.7 Time of Occupancy

 ,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,					
Test Requirement:	47 CFR Part 15C Section 15.247 (a)(1)				
Test Method:	ANSI C63.10:2013				
Test Setup:	Control Computer Power Supply Temperature Cabnet Table RF test System System Instrument				
	Remark: Offset=Cable loss+ attenuation factor.				
Test Procedure:					
Limit:	The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.				
Test Mode:	Hopping transmitting with all kind of modulation and all kind of data type.				
Test Results:	Refer to Appendix A				







4.8 Band edge Measurements

Test Requirement:	47 CFR Part 15C Section 15.247 (d)				
Test Method:	ANSI C63.10:2013				
Test Setup:	Control Computer Power Supply Power Fable RF test Control Computer Power Foot Attenuator Instrument Table	(cri)			
	Remark: Offset=Cable loss+ attenuation factor.				
Test Procedure:	 Set to the maximum power setting and enable the EU continuously. Set RBW = 100 kHz, VBW = 300 kHz (≥RBW). Band edge must be at least 20 dB down from the highest emission level with the authorized band as measured with a 100kHz RBW. The shall be 30 dB instead of 20 dB when RMS conducted ou procedure is used. Enable hopping function of the EUT and then repeat step 2 and 4. Measure and record the results in the test report. 	emissions nin attenuation tput power			
Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement.				
Exploratory Test Mode:	Hopping and Non-hopping transmitting with all kind of modulation of data type	and all kind			
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst cas modulation type, 2-DH5 of data type is the worst case of modulation type, 3-DH5 of data type is the worst case of 8DPSK type.	π/4DQPSK			
Test Results:	Refer to Appendix A				





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4.9 Conducted Spurious Emissions

 / 201						
Test Requirement:	47 CFR Part 15C Section 15.247 (d)					
Test Method:	ANSI C63.10:2013					
Test Setup:	Control Computer Power Supply Attenuator Instrument Table RF test System Instrument					
	Remark: Offset=Cable loss+ attenuation factor.					
Test Procedure:	 The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement. Set to the maximum power setting and enable the EUT transmit continuously. Set RBW = 100 kHz, VBW = 300kHz, scan up through 10th harmonic. All harmonics / spurs must be at least 20 dB down from the highest emission level within the authorized band as measured with a 100kHz RBW. Measure and record the results in the test report. The RF fundamental frequency should be excluded against the limit line in the operating frequency band. 					
Limit:	In any 100 kHz bandwidth outside the frequency band in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement.					
Exploratory Test Mode:	Non-hopping transmitting with all kind of modulation and all kind of data type					
Final Test Mode:	Through Pre-scan, find the DH5 of data type is the worst case of GFSK modulation type, 2-DH5 of data type is the worst case of $\pi/4DQPSK$ modulation type, 3-DH5 of data type is the worst case of 8DPSK modulation type.					
Test Results:	Refer to Appendix A					
10.0.						







4.10 Pseudorandom Frequency Hopping Sequence

Test Requirement: 47 CFR Part 15C Section 15.247 (a)(1), (h) requirement:

The system shall hop to channel frequencies that are selected at the system hopping rate from a Pseudorandom ordered list of hopping frequencies. Each frequency must be used equally on the average by each transmitter. The system receivers shall have input bandwidths that match the hopping channel bandwidths of their corresponding transmitters and shall shift frequencies in synchronization with the transmitted signals.

Frequency hopping spread spectrum systems are not required to employ all available hopping channels during each transmission. However, the system, consisting of both the transmitter and the receiver, must be designed to comply with all of the regulations in this section should the transmitter be presented with a continuous data (or information) stream. In addition, a system employing short transmission bursts must comply with the definition of a frequency hopping system and must distribute its transmissions over the minimum number of hopping channels specified in this section.

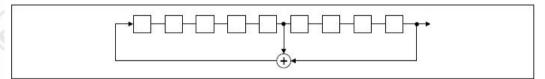
The incorporation of intelligence within a frequency hopping spread spectrum system that permits the system to recognize other users within the spectrum band so that it individually and independently chooses and adapts its hopsets to avoid hopping on occupied channels is permitted. The coordination of frequency hopping systems in any other manner for the express purpose of avoiding the simultaneous occupancy of individual hopping frequencies by multiple transmitters is not permitted.

Compliance for section 15.247(a)(1)

According to Bluetooth Core Specification, the pseudorandom sequence may be generated in a nine-stage shift register whose 5th and 9th stage

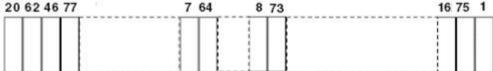
outputs are added in a modulo-two addition stage. And the result is fed back to the input of the first stage. The sequence begins with the first ONE of 9 consecutive ONEs; i.e. the shift register is initialized with nine ones.

- · Number of shift register stages: 9
- Length of pseudo-random sequence: 29 -1 = 511 bits
- Longest sequence of zeros: 8 (non-inverted signal)



Linear Feedback Shift Register for Generation of the PRBS sequence

An example of Pseudorandom Frequency Hopping Sequence as follow: 20 62 46 77 7 64 8 73



Each frequency used equally on the average by each transmitter.

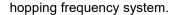
According to Bluetooth Core Specification, Bluetooth receivers are designed to have input and IF bandwidths that match the hopping channel bandwidths of any Bluetooth transmitters and shift frequencies in synchronization with the transmitted signals.

Compliance for section 15.247(g)

According to Bluetooth Core Specification, the Bluetooth system transmits the packet with the pseudorandom hopping frequency with a continuous data and the short burst transmission from the Bluetooth system is also transmitted under the frequency hopping system with the pseudorandom







Compliance for section 15.247(h)

According to Bluetooth Core specification, the Bluetooth system incorporates with an adaptive system to detect other user within the spectrum band so that it individually and independently to avoid hopping on the occupied channels.

According to the Bluetooth Core specification, the Bluetooth system is designed not have the ability to coordinated with other FHSS System in an effort to avoid the simultaneous occupancy of individual hopping frequencies by multiple transmitter.

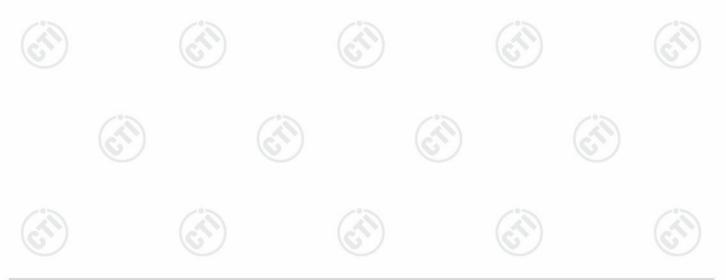




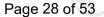


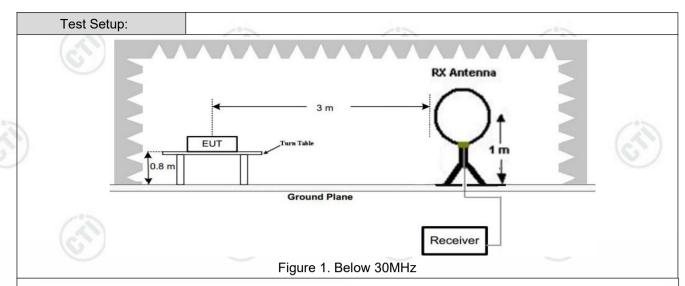
4.11 Radiated Spurious Emission & Restricted bands

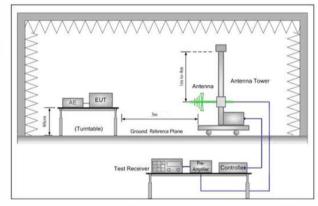
Test Requirement:	47 CFR Part 15C Secti	47 CFR Part 15C Section 15.209 and 15.205					
Test Method:	ANSI C63.10: 2013						
Test Site:	Measurement Distance: 3m (Semi-Anechoic Chamber)						
Receiver Setup:	Frequency		Detector	RBW	VBW	Remark	
	0.009MHz-0.090MH	z	Peak	10kHz	30kHz	Peak	
	0.009MHz-0.090MH	z	Average	10kHz	30kHz	Average	
	0.090MHz-0.110MH	Z	Quasi-peak	10kHz	30kHz	Quasi-peak	
	0.110MHz-0.490MH	Z	Peak	10kHz	30kHz	Peak	
	0.110MHz-0.490MH	Z	Average	10kHz	30kHz	Average	
	0.490MHz -30MHz		Quasi-peak	10kHz	30kHz	Quasi-peak	
	30MHz-1GHz		Peak	100 kH	z 300kHz	Peak	
	Ab 4011=		Peak	1MHz	3MHz	Peak	
	Above 1GHz		Peak	1MHz	10kHz	Average	
Limit:	Frequency	Field strength (microvolt/meter)		Limit (dBuV/m)	Remark	Measuremen	
	0.009MHz-0.490MHz	2	400/F(kHz)	-	-	300	
	0.490MHz-1.705MHz	24	1000/F(kHz)	-	-/3	30	
	1.705MHz-30MHz	30		-	(6)	30	
	30MHz-88MHz	100		40.0	Quasi-peak	3	
	88MHz-216MHz	150		43.5	Quasi-peak	3	
	216MHz-960MHz		200	46.0	Quasi-peak	3	
	960MHz-1GHz	(``)	500	54.0	Quasi-peak	3	
	Above 1GHz		500	54.0	Average	3	
	Note: 15.35(b), Unless emissions is 20dE applicable to the opeak emission lev	3 ab equi	ove the maxin	num permi est. This p	tted average	emission limit	











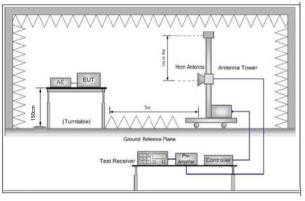


Figure 2. 30MHz to 1GHz

Figure 3. Above 1 GHz

Test Procedure:

- a. 1) Below 1G: The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter semi-anechoic camber. The table was rotated 360 degrees to determine the position of the highest radiation.
 - 2) Above 1G: The EUT was placed on the top of a rotating table 1.5 meters above the ground at a 3 meter semi-anechoic camber. The table was rotated 360 degrees to determine the position of the highest radiation.

Note: For the radiated emission test above 1GHz:

Place the measurement antenna away from each area of the EUT determined to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response. The measurement antenna may have to be higher or lower than the EUT, depending on the radiation pattern of the emission and staying aimed at the emission source for receiving the maximum signal. The final measurement antenna elevation shall be that which maximizes the emissions. The measurement antenna elevation for maximum emissions shall be restricted to a range of heights of from 1 m to 4 m above the ground or reference ground plane.

- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The antenna height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the